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APPLICATION NO.	FILING DATE	FIRST NAMED INVENTOR	ATTORNEY DOCKET NO.	CONFIRMATION NO.
10/614,108	07/08/2003	Tatsuya Shiromoto	239842US	7683
22850	7590 08/18/2004	·	EXAMINER	
OBLON, SPIVAK, MCCLELLAND, MAIER & NEUSTADT, P.C.			LEBENTRITT, MICHAEL	
1940 DUKE S ALEXANDR	STREET RIA, VA 22314		ART UNIT	PAPER NUMBER
	,		2824	
			DATE MAILED: 08/18/2004	

Please find below and/or attached an Office communication concerning this application or proceeding.

	Application No.	Applicant(s)					
	10/614,108	SHIROMOTO ET	AL.				
Office Action Summary	Examiner	Art Unit					
	Michael S. Lebentritt	2824					
The MAILING DATE of this communication ap Period for Reply	ppears on the cover sheet with the	correspondence ad	dress				
A SHORTENED STATUTORY PERIOD FOR REPITHE MAILING DATE OF THIS COMMUNICATION - Extensions of time may be available under the provisions of 37 CFR 1 after SIX (6) MONTHS from the mailing date of this communication. - If the period for reply specified above is less than thirty (30) days, a re - If NO period for reply is specified above, the maximum statutory period - Failure to reply within the set or extended period for reply will, by statu Any reply received by the Office later than three months after the mailie earned patent term adjustment. See 37 CFR 1.704(b).	136(a). In no event, however, may a reply be to ply within the statutory minimum of thirty (30) dad will apply and will expire SIX (6) MONTHS from the cause the application to become ABANDON	imely filed ays will be considered timely in the mailing date of this of ED (35 U.S.C. § 133).	y. ommunication.				
Status							
1) Responsive to communication(s) filed on							
·— · · —	is action is non-final.						
3) Since this application is in condition for allow		rosecution as to the	merits is				
,—	closed in accordance with the practice under Ex parte Quayle, 1935 C.D. 11, 453 O.G. 213.						
Disposition of Claims							
4) Claim(s) 1-4 is/are pending in the application	☑ Claim(s) <u>1-4</u> is/are pending in the application.						
4a) Of the above claim(s) is/are withdra	4a) Of the above claim(s) is/are withdrawn from consideration.						
5) Claim(s) is/are allowed.							
6)⊠ Claim(s) <u>1-4</u> is/are rejected.							
) Claim(s) is/are objected to.							
8) Claim(s) are subject to restriction and/	or election requirement.						
Application Papers							
9) The specification is objected to by the Examiner.							
10) The drawing(s) filed on is/are: a) accepted or b) objected to by the Examiner.							
Applicant may not request that any objection to the drawing(s) be held in abeyance. See 37 CFR 1.85(a).							
Replacement drawing sheet(s) including the correction is required if the drawing(s) is objected to. See 37 CFR 1.121(d).							
11)☐ The oath or declaration is objected to by the E	Examiner. Note the attached Offic	e Action or form PT	O-152.				
Priority under 35 U.S.C. § 119							
 12) Acknowledgment is made of a claim for foreig a) All b) Some * c) None of: 1. Certified copies of the priority documer 2. Certified copies of the priority documer 3. Copies of the certified copies of the priapplication from the International Burea 	nts have been received. nts have been received in Applica ority documents have been receiv	tion No. <u>10/164,62</u>					
* See the attached detailed Office action for a lis	* * * * * * * * * * * * * * * * * * * *	red.					
Attachment(s)							
1) Motice of References Cited (PTO-892)	4) Interview Summar						
 Notice of Draftsperson's Patent Drawing Review (PTO-948) Information Disclosure Statement(s) (PTO-1449 or PTO/SB/08 Paper No(s)/Mail Date 	Paper No(s)/Mail I 5) Notice of Informal 6) Other:		D-152)				

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DETAILED ACTION

Information Disclosure Statement

The information disclosure statement (IDS) submitted on August 02,2004 and July 08,2003 were filed before the mailing date of the first office action on the merits. The submission is in compliance with the provisions of 37 CFR 1.97. Accordingly, the information disclosure statements are being considered by the examiner.

Claim Rejections - 35 USC § 112

The following is a quotation of the second paragraph of 35 U.S.C. 112:

The specification shall conclude with one or more claims particularly pointing out and distinctly claiming the subject matter which the applicant regards as his invention.

Claims 1-4 are rejected under 35 U.S.C. 112, second paragraph, as being indefinite for failing to particularly point out and distinctly claim the subject matter which applicant regards as the invention.

In regard to claim 1, it is unclear at to which operating characteristic the claim is referring to, generally in flash memory devices there are three categories of operating, namely programming (writing), erasing and reading.

In regards to claim 2, it is unclear what is meant by "different drain formation conditions include conditions different from each other", according to the specification the drains are formed by using the memory cell as a mask.

In regards to claims 2-4, it is unclear as to what "condition" is different, temperature, ion dosage, energy source, time, etc.

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Claim Rejections - 35 USC § 102

The following is a quotation of the appropriate paragraphs of 35

U.S.C. 102 that form the basis for the rejections under this section made in this

Office action:

A person shall be entitled to a patent unless -

(e) the invention was described in (1) an application for patent, published under section 122(b), by another filed in the United States before the invention by the applicant for patent or (2) a patent granted on an application for patent by another filed in the United States before the invention by the applicant for patent, except that an international application filed under the treaty defined in section 351(a) shall have the effects for purposes of this subsection of an application filed in the United States only if the international application designated the United States and was published under Article 21(2) of such treaty in the English language.

Claim 1 is rejected under 35 U.S.C. 102(e) as being anticipated by Ohnakado et al, US Patent 6,635,920

The applied reference has a common inventor with the instant application. Based upon the earlier effective U.S. filing date of the reference, it constitutes prior art under 35 U.S.C. 102(e). This rejection under 35 U.S.C. 102(e) might be overcome either by a showing under 37 CFR 1.132 that any invention disclosed but not claimed in the reference was derived from the inventor of this application and is thus not the invention "by another," or by an appropriate showing under 37 CFR 1.131.

Ohnakado discloses (as interpreted by examiner in regards to the 112 2nd paragraph rejection); (a) preparing a semiconductor substrate (1); (b) forming a plurality of gate structures (2) on said semiconductor substrate, each of said plurality of gate structures including a multi-layer structure having a first insulation film, a floating gate electrode (2a), a second insulation film (2b) and a control gate electrode (2c) stacked in the order named, said plurality of gate

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structures including first and second gate structures formed in first and second non-volatile memory cell regions, respectively; (c) forming a first drain region (4a) in said first non-volatile memory cell region under a first drain formation condition by using said first gate structure as a mask; (d) forming a second drain region (4b) in said second non-volatile memory cell region under a second drain formation condition by using said second gate structure as a mask; (e) forming a first source (3a) region in said first non-volatile memory cell region under a first source formation condition by using said first gate structure as a mask, said first gate structure, said first drain region and said first source region constituting a first memory cell transistor having a first operating characteristic; and forming a second source region (3b) in said second non-volatile memory cell region under a second source formation condition by using said second gate structure as a mask, said second gate structure, said second drain region and said second source region constituting a second memory cell transistor having a second operating characteristic. Writing operation is carried out by injecting hot carrier into the floating gate while erasing operation is carried out by FN tunnel phenomenon.

See figure 1-11 and discussion on column 6, line 60 to column 9, line 20.

Allowable Subject Matter

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Claims 2-4 are objected to as being dependent upon a rejected base claim, but would be allowable if rewritten in independent form including all of the limitations of the base claim and any intervening claims.

The following is a statement of reasons for the indication of allowable subject matter: prior art references fail to teach: Wherein said first memory cell transistor includes NOR-type memory cell transistor and said second memory cell transistor includes a DiNOR-type memory cell transistor.

Conclusion

Any inquiry concerning this communication or earlier communications from the examiner should be directed to Michael S. Lebentritt whose telephone number is 571-272-1873. The examiner can normally be reached on 5/4/9.

If attempts to reach the examiner by telephone are unsuccessful, the examiner's supervisor, Richard Elms can be reached on 571-272-1869. The fax phone number for the organization where this application or proceeding is assigned is 703-872-9306.

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Information regarding the status of an application may be obtained from the Patent Application Information Retrieval (PAIR) system. Status information for published applications may be obtained from either Private PAIR or Public PAIR. Status information for unpublished applications is available through Private PAIR only. For more information about the PAIR system, see http://pair-direct.uspto.gov. Should you have questions on access to the Private PAIR system, contact the Electronic Business Center (EBC) at 866-217-9197 (toll-free).

Michael S. Lebentritt Primary Examiner Art Unit 2824
